

<b>Notice of References Cited</b>		Application/Control No. 10/752,396	Applicant(s)/Patent Under Reexamination GUTIERREZ-SHERIS, LUIS E	
		Examiner JOHN M. WINTER	Art Unit 3685	Page 1 of 3

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Examiner

JOHN M. WINTER

Art Unit

3685

Page 2 of 3

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Art Unit

3685

Page 3 of 3

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